

<b>Notice of References Cited</b>	Application/Control No. 10/569,968		Applicant(s)/Patent Under Reexamination DEMIR ET AL.	
	Examiner NATHAN T. LEONG		Art Unit 1715	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,159,370	12-2000	Hicke et al.	210/500.43
*	B	US-5,681,617	10-1997	Lin et al.	427/299
*	C	US-6,346,136	02-2002	Chen et al.	75/343
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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